Notice of References Cited

Application/Control No.		Applicant(s)/Patent Under		
09/640,729		Reexamination HERTWIG ET AL.		
Examiner	Art Unit			
Ravmond Phan	2181	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6353863	03-2002	Nakagawa et al.	710/5
7	В	US-6526462	02-2003	Elabd	710/242
	10	US-5867726	02-1999	Ohsuga et al.	709/20
/	D	US-4881164	11-1989	Hailpern et al.	711/207
1	Æ	US-5903771	05-1999	Sgro et al.	712/20
\Box	F	US-6163828	12-2000	Landi et al.	710/240
7	G	US-5685005	11-1997	Garde et al.	712/1
4	Н	US-5592677	01-1997	Intrater et al.	712/1
Z	٦ .	*US-5974493	10-1999	Okummura et al.	710/127
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1 067 461 A1	08-1999	EPO	Chauvel et al.	G06F 13/16
	0					
	Р					
	σ					
	R					
	s					
	T					

NON-PATENT DOCUMENTS

	NORT ATENT DOCUMENTO			
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	٧			
	w			
	х			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.